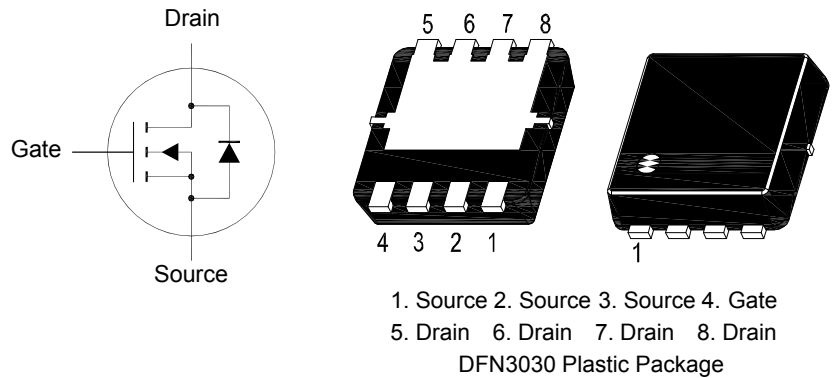


SFTN6016MP

N-Channel Enhancement Mode MOSFET



Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-Source Voltage	V_{DS}	60	V
Drain-Gate Voltage	V_{GS}	± 20	V
Drain Current - Continuous ¹⁾	I_D	$T_C = 25^\circ\text{C}$ 44	A
		$T_C = 100^\circ\text{C}$ 28	
Drain Current – Pulse ²⁾	I_{DM}	100	A
Power Dissipation ³⁾	P_D	42	W
Operating Junction and Storage Temperature Range	T_j, T_{stg}	- 55 to + 150	$^\circ\text{C}$

Thermal Characteristics

Parameter	Symbol	Max.	Unit
Thermal Resistance - Junction to Ambient ¹⁾	$R_{\theta JA}$	75	$^\circ\text{C/W}$
Thermal Resistance - Junction to Case ¹⁾	$R_{\theta JC}$	3	$^\circ\text{C/W}$

¹⁾ The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

²⁾ The data tested by pulsed , pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$.

³⁾ The power dissipation is limited by 150 $^\circ\text{C}$ junction temperature.

SFTN6016MP

Characteristics at $T_J = 25^\circ\text{C}$ unless otherwise specified

Parameter	Symbol	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage at $I_D = 250\ \mu\text{A}$	BV_{DSS}	60	-	-	V
Gate-Source Threshold Voltage at $V_{GS} = V_{DS}$, $I_D = 250\ \mu\text{A}$	V_{GSth}	1.2	-	2.5	V
Drain-Source Leakage Current at $V_{DS} = 48\ \text{V}$, $T_J = 25^\circ\text{C}$ at $V_{DS} = 48\ \text{V}$, $T_J = 55^\circ\text{C}$	I_{DSS}	- -	- -	1 5	μA
Gate-Source Leakage Current at $V_{GS} = \pm 20\ \text{V}$	I_{GSS}	-	-	± 100	nA
Drain-Source On-State Resistance at $V_{GS} = 10\ \text{V}$, $I_D = 8\ \text{A}$ at $V_{GS} = 4.5\ \text{V}$, $I_D = 6\ \text{A}$	$R_{DS(on)}$	- -	- -	12 15	m Ω
Forward Transconductance at $V_{DS} = 5\ \text{V}$, $I_D = 8\ \text{A}$	$ g_{FS} $	-	75	-	S
Input Capacitance at $V_{GS} = 0\ \text{V}$, $V_{DS} = 15\ \text{V}$, $f = 1\ \text{MHz}$	C_{iss}	-	3240	-	pF
Output Capacitance at $V_{GS} = 0\ \text{V}$, $V_{DS} = 15\ \text{V}$, $f = 1\ \text{MHz}$	C_{oss}	-	210	-	pF
Reverse Transfer Capacitance at $V_{GS} = 0\ \text{V}$, $V_{DS} = 15\ \text{V}$, $f = 1\ \text{MHz}$	C_{rss}	-	146	-	pF
Turn-On Delay Time at $V_{GS} = 10\ \text{V}$, $V_{DD} = 30\ \text{V}$, $R_G = 3.3\ \Omega$, $I_D = 8\ \text{A}$	$t_{d(on)}$	-	10.4	-	ns
Turn-On Rise Time at $V_{GS} = 10\ \text{V}$, $V_{DD} = 30\ \text{V}$, $R_G = 3.3\ \Omega$, $I_D = 8\ \text{A}$	t_r	-	9.2	-	ns
Turn-Off Delay Time at $V_{GS} = 10\ \text{V}$, $V_{DD} = 30\ \text{V}$, $R_G = 3.3\ \Omega$, $I_D = 8\ \text{A}$	$t_{d(off)}$	-	63	-	ns
Turn-Off Fall Time at $V_{GS} = 10\ \text{V}$, $V_{DD} = 30\ \text{V}$, $R_G = 3.3\ \Omega$, $I_D = 8\ \text{A}$	t_f	-	4.8	-	ns

Drain-Source Diode Characteristics and Maximum Ratings

Parameter	Symbol	Max.	Unit
Continuous Source-Drain Diode Current ^{1) 3)}	I_S	44	A
Pulsed Diode Forward Current ^{2) 3)}	I_{SM}	100	A

¹⁾ The data tested by surface mounted on a 1 inch² FR-4 board with 20Z copper.

²⁾ The data tested by pulsed, pulse width $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.

³⁾ The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.

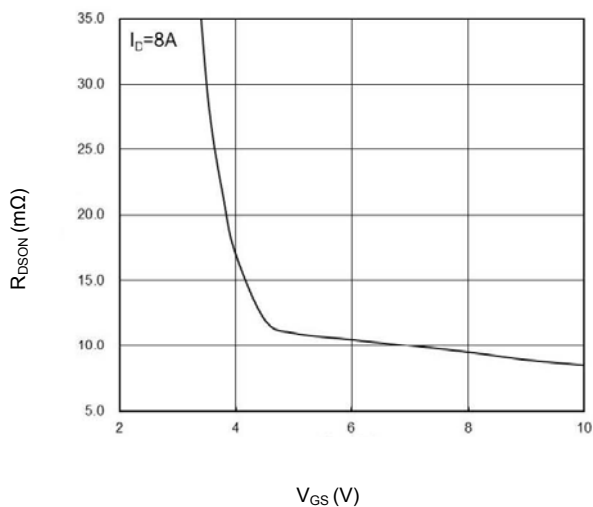


Figure 1.On Resistance vs. Gate Source Voltage

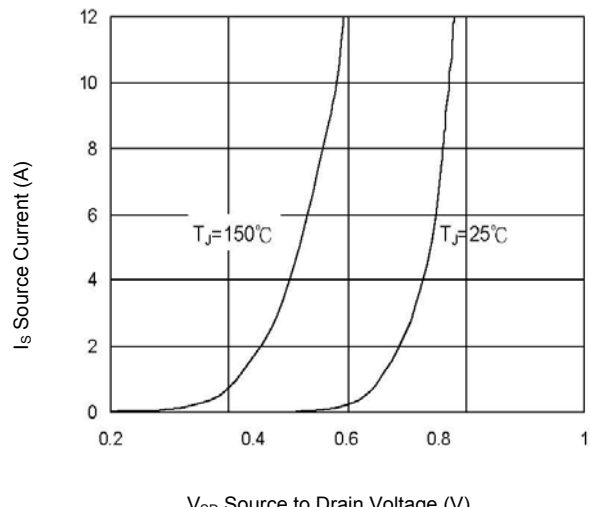


Figure 2.Forward Characteristics of Reverse

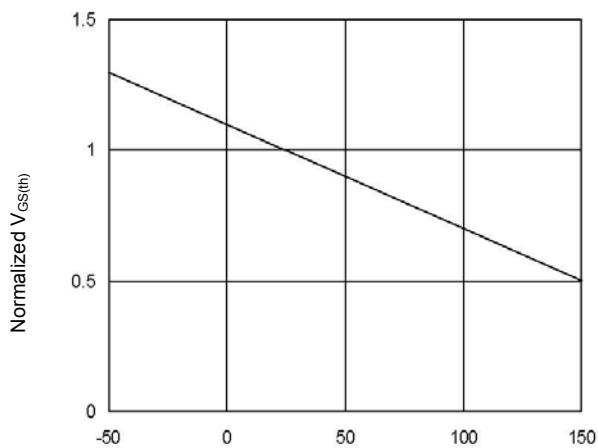


Figure 3.Normalized $V_{GS(th)}$ vs. T_J

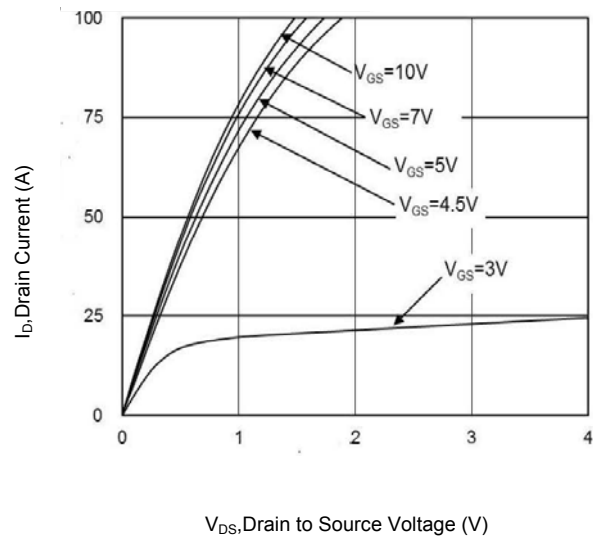
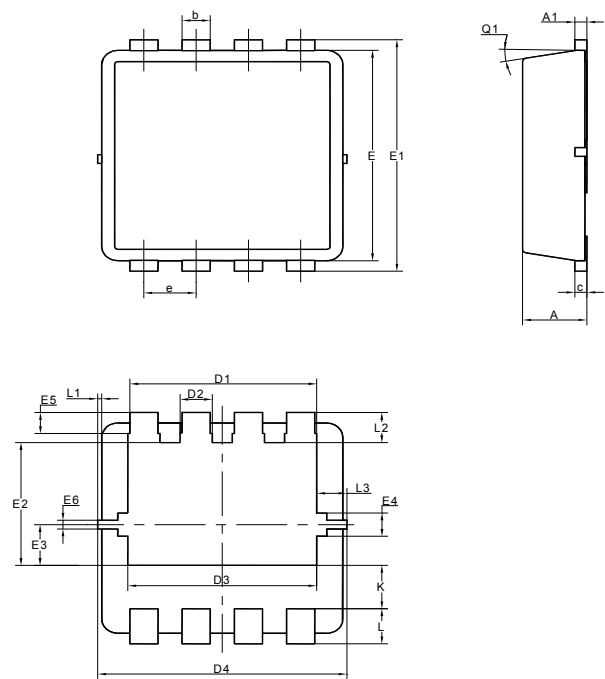


Figure 4.Typical Output Characteristics

SFTN6016MP

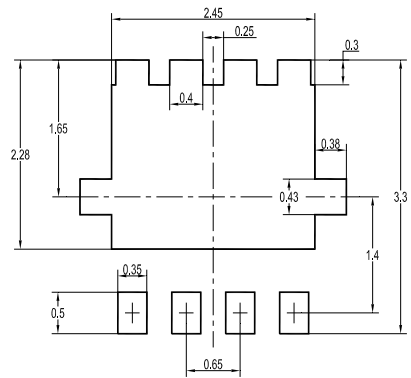
DFN3030 Package Outline Dimensions (Units: mm)



UNIT	A	A1	b	c	D	D1	D2	D3	D4	E	E1	E2	E3
mm	0.9	0.05	0.35	0.25	3.1	2.45	0.5	2.7	3.2	3.1	3.3	1.85	0.68
	0.7	0	0.24	0.1	2.9	2.25	0.3	2.5	3	2.9	3.1	1.65	0.48

UNIT	E4	E5	E6	e	K	L	L1	L2	L3	θ1
mm	0.43	0.4	0.175	0.7	0.72	0.5	0.1	0.53	0.475	12°
	0.23	0.2	0.075	0.6	0.52	0.3	0	0.33	0.275	0°

Recommended Soldering Footprint



Packing information

Package	Tape Width (mm)	Pitch		Reel Size		Per Reel Packing Quantity
		mm	inch	mm	inch	
DFN3030	8	4 ± 0.1	0.157 ± 0.004	330	13	3,000

Winning
Team
互創國際